

Search Notes

Application/Control No.

10/720,030

Examiner

Daniel Pan

Applicant(s)/Patent under
Reexamination

HEISHI ET AL.

Art Unit

2183

SEARCHED

Class	Subclass	Date	Examiner
712	210	8/15/2006	DP
<i>updated 8/15/06 n</i>			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR.
west pgp uspat jpoabs epoabs derwent ibm ieee npl 717/136,137 trans, 712/213,227	8/15/2006	DP
<i>updated 8/15/06 n</i>		